

Notice of References Cited	Application/Control No. 10/849,506	Applicant(s)/Patent Under Reexamination ISHAK, ANDREW	
	Examiner Deborah A. Raizen	Art Unit 2873	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,145,984	11-2000	Farwig, Michael J.	351/49
	B	US-4,878,748	11-1989	Johansen et al.	351/44
	C	US-6,334,680	01-2002	Larson, Charles P.	351/159
	D	US-5,702,819	12-1997	Gupta et al.	428/412
	E	US-6,220,703	04-2001	Evans et al.	351/163
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Willard et al., Instrumental Methods of Analysis, 6th Edition, 1981, pp. 67-68
	V	NACL website, as archived from October 8, 2000: http://web.archive.org/web/20001008003354/http://www.nacl.com/custom.htm obtained from WayBack Machine at www.archive.org
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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